

**APPLICATION
FOR
UNITED STATES LETTERS PATENT**

TITLE: SENSING WORD GROUPS IN A MEMORY

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Express Mail No. EV 337934715 US

Date: June 30, 2003

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SENSING WORD GROUPS IN A MEMORY

Background

Certain nonvolatile memories, such as a synchronous flash memory, that support "burst" data have a sense circuit that senses all data within a maximum non-continuous burst length at one time and places the data in an output buffer. On such devices, once an address is supplied to the device, it will wait for some initial latency count while all burst data starting from the initial address is sensed and transferred to the output buffer. The data is then output one unit per clock cycle until all sensed data is transferred to the requester.

In cases where the burst length requested by a memory controller is half of the sense width of the memory, half of the sensed data is not used by the controller. Even with address pipelining, if the initial latency count is more than the burst length, there are wasted bus cycles. Thus, there is a need for alternate ways to retrieve information from memory.

20 Brief Description of the Drawings

FIG. 1 is a block diagram of a memory device read path in accordance with one embodiment of the present invention.

FIG. 2 is a timing diagram of synchronous burst read operations in accordance with one embodiment of the present invention.

FIG. 3 is a block diagram of a system with which 5 embodiments of the present invention may be used.

Detailed Description

Turning to FIG. 1, shown is a block diagram of a memory device read path in accordance with one embodiment of the present invention. As shown in FIG. 1, a memory 10 device may include an input stage 105, address latches 110 and 115, control logic 150, a buffer or output multiplexer 140, an output stage 145, sense arrays 130 and 135, and a memory array 120.

Address latches 110 and 115 and output multiplexer 140 15 may temporarily store information. As used herein, the terms "information" and "data" may be used interchangeably, and may refer to both data and instructions. Address latches 110 and 115 and output multiplexer 140 may be, for example, registers, queues, or latches, although the scope 20 of the present invention is not limited in this respect. Output multiplexer 140 may be adapted to store 256 bits of information, although the scope of the present invention is not limited in this respect. As shown in the embodiment of FIG. 1, output multiplexer 140 may output 32 bytes of 25 information.

In alternate embodiments, output multiplexer 140 may be adapted to store more or less than 256 bits of information. While shown as a single structure in FIG. 1, in other embodiments dedicated output buffers corresponding to sense arrays 130 and 135 respectively, may be provided.

Address latches 110 and 115 may receive read requests from a memory controller (not shown in FIG. 1) via input stage 105. These requests may specify the amount of information to be retrieved from memory array 120 and may 10 also include an address or addresses of the storage locations of the requested information in memory array 120.

After receiving read requests, sense arrays 130 and 135 may be used to sense the information at the requested addresses in memory array 120. Sense arrays 130 and 135 15 may include, for example, sense amplifiers (not shown) to sense the information stored in memory array 120. As shown in FIG. 1, each sense array may output 128 bits, although the scope of the present invention is not limited in this regard. While shown in FIG. 1 as separate arrays, it is to 20 be understood that while logically separate, in various embodiments such arrays may be a single physical structure having a plurality of sense amplifiers and appropriate routing circuitry to sense information from different initial addresses. Both sense arrays 130 and 135 may be 25 configured to be used together to sense 256 bits of continuous data, or separately to sense 128 bits of data

from two different addresses, although the scope of the present invention is not limited in this regard.

After sensing the requested information from memory array 120, this information may be transferred to output multiplexer 140. The retrieved information may be transmitted from output multiplexer 140 via output stage 145 to a processor for use therein.

Control logic 150 may include circuitry to control the accessing and retrieval of information from memory array 120. For example, control logic 150 may be adapted to receive control, data, and/or address signals from a memory controller of a host system. In some embodiments, control logic 150 may decode a received address, store the decoded address in address latches 110 and 115, enable sense arrays 130 and 135 to sense information stored at the decoded address in memory array 120, and transfer the sensed information to output multiplexer 140. In certain embodiments, control logic 150 may also determine which address latch is enabled for a given sense operation, for example, by determining which latch has a valid address for read sensing. In certain embodiments, two read-state machine (RSM) latency counters may be used to keep track of two overlapping sense operations. In the embodiment of FIG. 1, such RSM counters may be implemented in control logic 150.

Thus in certain embodiments, a bus data rate may be improved by separating a sense array (logically and/or physically) to sense data from more than one non-contiguous initial address. The bus rate may be optimized when a 5 burst length requested by the controller is half of the sense width, in certain embodiments. For example in one embodiment, a 256 bit sense array may sense two word groups, each four double words long, and each from a different initial address. In such an embodiment, the two 10 requests may be separated by four clock cycles, and half of the sense amplifiers in the array may be selected to sense each request. However, the scope of the present invention is not so limited, and in other embodiments a word group may be two or more units of data.

15 A memory device in accordance with one embodiment of the present invention may perform synchronous burst read operations. A synchronous read operation may refer to synchronously reading information from the memory device using a clock signal of a host system. That is, 20 information may be synchronously transmitted between a processor, a memory controller, and the memory device using a common reference clock. A burst read may refer to retrieving more than one unit of data in response to a single read request. A unit of data may be a byte of data, 25 a word of data, or a double word of data. It should be noted that the terms "byte," "word," "double word," are

terms denoting different units of data. As an example, in certain embodiments a byte of data may refer to eight bits of data, a word may refer to 16 bits of data, and a double word may refer to 32 bits of data, although the scope of 5 the present invention is not limited in this regard.

Referring now to FIG. 2, shown is a timing diagram illustrating synchronous burst read requests to retrieve information from a memory device in accordance with an embodiment of the present invention. The timing diagram of 10 FIG. 2 illustrates the relative timing of signals Clock (CLK), ADDRESS, Address Valid (ADV#), WAIT, and Data (DQ) that may be transferred between a memory controller and a memory device.

In this embodiment, twenty-two clock cycles of a clock 15 signal (labeled CLK) are illustrated. Address signals (labeled ADDRESS) may be transmitted to a memory device from a memory controller using a bus. As shown in FIG. 2, read requests may be initiated every four clock cycles (respectively, cycles 0, 4, 8, 12, 16 and 20). In some 20 embodiments, these read requests may be initiated by a processor of a host system and transferred to a memory controller at substantially the same time or at different times. In response, the memory controller may control when these read requests are transferred to the memory device.

25 In this embodiment, fixed-length synchronous burst read operations are illustrated, in that a fixed number of

words are requested during each read request. For example, initial read request X0 at clock cycle 0 requests the retrieval of four double words of information from addresses X0 through X3, respectively. In this example, 5 one double word of information is located at each address. Similarly, the second read request (Y0) at clock cycle 4 requests four double words of information respectively from addresses Y0 through Y3, and so forth for additional read requests.

10 The read requests may be referred to as burst read requests since more than one unit of data is transmitted from the memory device in response to a single read request. However, the amount of information retrieved in response to a single read request is not limited in this 15 respect. Although four double word synchronous burst reads are illustrated in the timing diagram of FIG. 2, other fixed-length synchronous burst reads may be realized in other embodiments. In addition, continuous synchronous burst read operations, rather than fixed-length operations, 20 may be implemented in other embodiments.

The Valid Address signal (labeled ADV#) may be transmitted to the memory device and may indicate that a valid address is available on the ADDRESS signal line.

During operation of a host system, read requests may 25 be transferred from a memory controller to the memory device via a bus. In various embodiments, read requests

may be received via input stage 105 at address latches 110 and 115 and/or control logic 150. In some embodiments, after receiving read requests, control logic 150 may enable retrieval of the information from memory array 120. For 5 example, control logic 150 may enable sensing of word groups, such as four double word groups of information located at two different initial addresses of memory array 120. Sense arrays 130 and 135 may each sense the four double words of information from these locations, and 10 control logic 150 may enable transfer of this information to output multiplexer 140. In alternate embodiments, control logic 150 may enable sense arrays 130 and 135 to sense eight double words from a single initial address.

The amount of time to retrieve information from memory 15 device 140 in response to a read request may be referred to as a latency time or latency count and may be measured in terms of clock cycles of signal CLK. The latency count may be based on factors such as, for example, the processing speed of the memory device and other characteristics of the 20 components of the memory device. In some embodiments, the time to retrieve information from a memory device in response to a read request may be programmable.

In the embodiment illustrated in FIG. 2, the latency count is six clock cycles of signal CLK. In other words, 25 at least six clock cycles after receiving read request X0, the double word of information stored at address location

X0 is transferred out of the memory device via output stage 145 on the DQ signal line. In the embodiment of FIG. 2, the WAIT signal may indicate (on a transition to logic low), the presence of valid data on the DQ line.

5 Similarly, the time interval T_{Chqv} may indicate the interval of time from the sixth clock cycle until the presence of valid data.

In the embodiment of FIG. 2, during the six clock cycles after receiving the X0 read request, the following 10 may occur with respect to this read request: control logic 150 may decode the received addresses; sense array 130 may sense four double words of information respectively located at addresses X0 to X3; control logic 150 may enable transferring of the sensed four double words to output 15 multiplexer 140; and control logic 150 may enable transferring of the first double word of information associated with address X0 from output multiplexer 140.

In the embodiment of FIG. 2, in response to read request Y0, information may be sensed by sense array 135 20 overlapping with the sensing of least part of the information in response to read request X0 by sense array 130. Such sensing of the Y0 request may continue while information retrieved in response to read request X0 is transferred out of the memory device. As soon as sense 25 array 130 has completed sensing data for read request X0, it may start sensing data for the next read request Z0.

This may be referred to as pipelining or a pipelining process. In certain embodiments, the WAIT signal may comprehend multiple pipelined read cycles being requested, and may provide the appropriate value (i.e., high or low)

5 to indicate data validity/invalidity. In such embodiments, the WAIT signal may be dependent upon, for example, the initial latency, read request timing (i.e., ADV# pulses), and addressing.

In the embodiment of FIG. 2, the four double words
10 retrieved in response to read request Y0 are transferred from the memory device directly following the information transferred in response to the X0 read request. In other words, no invalid data or wait states appear on the bus between the information output in response to read requests
15 X0 and Y0.

The reading of information as shown in FIG. 2 may be referred to as optimal pipelining. The term optimal pipelining may refer to the process of issuing at least two read requests, where the subsequent request is transferred
20 to the memory at a predetermined time so that all the requested information is output in response to the initial request and all the information in response to the subsequent request is output from the memory directly following the information retrieved in response to the
25 initial request. In the embodiment of FIG. 2, optimal

pipelining is achieved by transferring read request Y0 to memory array 120 four clock cycles after read request X0.

The memory device of FIG. 1 may be adapted to store information such as, for example, instructions or data used 5 by an operating system or a software program that may be executed by a processor. In some embodiments, a memory device may be a volatile memory such as, for example, a static random access memory (SRAM) or a dynamic random access memory (DRAM), although the scope of the claimed 10 subject matter is not limited in this respect. In alternate embodiments, the memory device may be a nonvolatile memory such as, for example, an electrically programmable read-only memory (EPROM), an electrically erasable and programmable read only memory (EEPROM), a 15 flash memory (NAND or NOR type, including multiple bits per cell), a ferroelectric random access memory (FRAM), a disk memory such as, for example, an electromechanical hard disk, an optical disk, a magnetic disk, or any other device capable of storing instructions and/or data. Other types 20 of nonvolatile memory are also within the scope of the claimed subject matter, including volatile memory with a battery backup, as the battery may prevent the memory from losing its contents when the main power source is off.

Further, embodiments may be implemented in a computer 25 program, and stored on a storage medium (such as those described above) having stored thereon instructions which

can be used to program a computer system, wireless device or the like to perform the embodiments.

FIG. 3 is a block diagram of a representative data processing system, namely computer system 300 with which 5 embodiments of the invention may be used. In one embodiment, computer system 300 includes a processor 310, which may include a general-purpose or special-purpose processor such as a microprocessor, microcontroller, application specific integrated circuit (ASIC), a 10 programmable gate array (PGA), and the like.

The processor 310 may be coupled over a host bus 315 to a memory hub (i.e., a memory controller) 330 in one embodiment, which may be coupled to a system memory 320 via a memory bus 325. The memory hub 330 may also be coupled 15 over an Advanced Graphics Port (AGP) bus 333 to a video controller 335, which may be coupled to a display 337. The AGP bus 333 may conform to the Accelerated Graphics Port Interface Specification, Revision 2.0, published May 4, 1998, by Intel Corporation, Santa Clara, California.

20 Memory hub 330 may control the transfer of information within system 300, e.g., between processor 310, memory hub 330, and memory 320. That is, memory hub 330 may generate control signals, address signals, and data signals that may be associated with a particular write or read operation to 25 memory 320.

In some embodiments, memory hub 330 may be integrated with processor 310 and/or with memory 320. In alternate embodiments, memory hub 330 may be a discrete component or dedicated chip. In other embodiments, portions of the 5 functionality of memory hub 330 may be implemented in processor 310 or in memory 320 as, for example, a software application, module, or routine.

The memory hub 330 may also be coupled (via a hub link 338) to an input/output (I/O) hub 340 that is coupled to a 10 input/output (I/O) expansion bus 342 and a Peripheral Component Interconnect (PCI) bus 344, as defined by the PCI Local Bus Specification, Production Version, Revision 2.1 dated in June 1995, or alternately a bus such as the PCI Express bus, or another third generation I/O interconnect 15 bus. The I/O expansion bus 342 may be coupled to an I/O controller 346 that controls access to one or more I/O devices. As shown in FIG. 3, these devices may include in one embodiment storage devices, such as a floppy disk drive 350 and input devices, such as keyboard 352 and mouse 354. 20 The I/O hub 340 may also be coupled to, for example, a hard disk drive 356 as shown in FIG. 3. It is to be understood that other storage media may also be included in the system. In an alternate embodiment, the I/O controller 346 may be integrated into the I/O hub 340, as may other 25 control functions.

The PCI bus 344 may be coupled to various components including, for example, a flash memory 360 which may include the structure shown in the block diagram of FIG. 1. Further shown in FIG. 3 is a wireless interface 362 coupled 5 to the PCI bus 344, which may be used in certain embodiments to communicate with remote devices. As shown in FIG. 3, wireless interface 362 may include a dipole or other antenna 363 (along with other components not shown in FIG. 3). In various embodiments, wireless interface 362 10 may be coupled to system 300, which may be a notebook personal computer, via an external add-in card, or an embedded device. In other embodiments wireless interface 362 may be fully integrated into a chipset of system 300.

Although the description makes reference to specific 15 components of the system 300, it is contemplated that numerous modifications and variations of the described and illustrated embodiments may be possible. More so, while FIG. 3 shows a block diagram of a system such as a notebook personal computer, it is to be understood that embodiments 20 of the present invention may be implemented in another wireless device such as a cellular phone, personal digital assistant (PDA) or the like. In such embodiments, a flash memory in accordance with an embodiment may be coupled to an internal bus which is in turn coupled to a 25 microprocessor and a peripheral bus, which may in turn be coupled to a wireless interface and an associated antenna

such as a dipole antenna, helical antenna, global system for mobile communication (GSM) antenna, and the like.

While the present invention has been described with respect to a limited number of embodiments, those skilled 5 in the art will appreciate numerous modifications and variations therefrom. It is intended that the appended claims cover all such modifications and variations as fall within the true spirit and scope of this present invention.